

#### 650V 30A Trench and Field Stop IGBT

#### JJT30N65SE

## **Key performance:**

- $V_{\rm CE}$ =650V
- $I_{\rm C}=30$ A@ $T_{\rm C}=100$ °C
- $V_{\text{CE(sat)}}=1.7 \text{ V}$

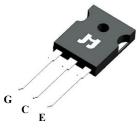
#### **Features:**

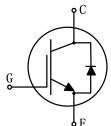
- High ruggedness performance.
- 10μs short circuit capability.
- Positive  $V_{\text{CE (sat)}}$  temperature coefficient.
- High efficiency for motor control.
- Excellent current sharing in parallel operation.
- RoHS compliant.

#### **Applications:**

- Home appliances
- Motor drives
- General inverter

#### TO-247





#### Package parameters

Туре	Marking	Package	Packaging method
JJT30N65SE	T3065SE	TO-247	Tube



# **Maximum ratings**

Symbol	Parameter	Values	Unit
$V_{\mathrm{CES}}$	Collector-emitter voltage	650	V
$V_{ m GES}$	Gate-emitter voltage	±20	V
7	Continuous collector current (T <sub>C</sub> =25°C)	60	A
$I_{\mathrm{C}}$	Continuous collector current (T <sub>C</sub> =100°C)	30	A
$I_{\mathrm{CM}}$	Pulsed collector current, $t_p$ limited by $T_{vjmax}$	120	A
$I_{ m F}$	Diode continuous forward current (T <sub>C</sub> =100°C)	30	A
$I_{ m FM}$	Diode maximum current, $t_p$ limited by $T_{vjmax}$	80	A
$t_{ m sc}$	Short circuit withstand time	10	μs
D	Power dissipation ( $T_{\rm C}$ =25°C)	300	W
$P_{tot}$	Power dissipation ( $T_{\rm C}$ =100°C)	150	W
$T_{ m vj}$	Operating junction temperature range	-40 to +175	°C
$T_{ m stg}$	Storage temperature range	-55 to +150	°C

#### Thermal characteristics

Cl1	D	Val	T1:4	
Symbol	Parameter		Max.	Unit
$R_{ m th(j-c)}$	Thermal resistance, junction to case for IGBT	-	0.5	K/W
$R_{ m th(j-c)}$	Thermal resistance, junction to case for Diode		0.9	K/W
$R_{ m th(j-a)}$	Thermal resistance, junction to ambient	-	40	K/W



# **Electrical characteristics of IGBT** $(T_{vj}=25^{\circ}\text{C} \text{ unless otherwise specified})$

## Static characteristics

Cymah al	D	T-4 - 1'4'	Values			II. *4
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
$BV_{\rm CES}$	Collector-emitter breakdown voltage	$V_{\rm GE} = 0 \text{V}, I_{\rm C} = 250 \mu \text{A}$	650	-	-	V
$I_{\mathrm{CES}}$	Collector-emitter leakage current	$V_{\rm CE}$ =650V, $V_{\rm GE}$ =0V	-	-	50	μА
I	Gate leakage current, forward	$V_{\rm GE} = 20  \text{V}, \ V_{\rm CE} = 0  \text{V}$	-	-	100	nA
$I_{\text{GES}}$	Gate leakage current, reverse	$V_{\rm GE}$ =-20V, $V_{\rm CE}$ =0V	-	-	-100	nA
$V_{\mathrm{GE(th)}}$	Gate-emitter threshold voltage	$V_{\rm GE} = V_{\rm CE}, I_{\rm C} = 1 \mathrm{mA}$	5.3	5.7	5.9	V
$V_{\mathrm{CE(sat)}}$		$V_{\rm GE} = 15 \text{V}, I_{\rm C} = 30 \text{A}$	-	1.7	-	V
	Collector-emitter saturation voltage	$V_{\text{GE}} = 15\text{V}, I_{\text{C}} = 30\text{A}, T_{\text{vj}} = 175^{\circ}\text{C}$	-	2.2	-	V

# Dynamic characteristics

C	D	Tr. 4 . 1'4'	Values			Unit
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
$C_{\mathrm{ies}}$	Input capacitance	$V_{\rm CE}$ =30V	-	1978	1	pF
$C_{ m oes}$	Output capacitance	$V_{\text{CE}}$ = 30 V $V_{\text{GE}}$ = 0 V f = 1 MHz	-	100	-	pF
$C_{\rm res}$	Reverse transfer capacitance		-	23	-	pF
$Q_{ m g}$	Total gate charge	$V_{\text{CC}}$ =520V $V_{\text{GE}}$ =15V $I_{\text{C}}$ =30A	-	103	-	nC



# Switching characteristics

	Danamatan	Tr. 4 1141	Values			T124
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
$t_{ m d(on)}$	Turn-on delay time		-	30	-	ns
$t_{ m r}$	Rise time		-	39	-	ns
$t_{ m d(off)}$	Turn-off delay time	$V_{\text{CC}}$ =400V $V_{\text{GE}}$ =0/15V	-	151	-	ns
$t_{ m f}$	Fall time	$I_{C}=30A$ $R_{G}=10\Omega$	-	29	-	ns
$E_{ m on}$	Turn-on energy	Inductive load	-	0.95	-	mJ
$E_{ m off}$	Turn-off energy		-	0.60	-	mJ
$E_{\mathrm{ts}}$	Total switching energy		-	1.55	-	mJ
$t_{ m d(on)}$	Turn-on delay time		-	28	-	ns
$t_{ m r}$	Rise time	V <sub>CC</sub> =400V	-	40	-	ns
$t_{ m d(off)}$	Turn-off delay time	$V_{\rm GE} = 0/15 { m V}$	-	169	-	ns
$t_{ m f}$	Fall time	$I_{\rm C}$ =30A $R_{\rm G}$ =10 $\Omega$ Inductive load $T_{\rm vj}$ =175 °C	-	71	-	ns
$E_{ m on}$	Turn-on energy		-	1.5	-	mJ
$E_{ m off}$	Turn-off energy		-	0.8	-	mJ
$E_{\mathrm{ts}}$	Total switching energy		-	2.3	-	mJ



# **Electrical characteristics of Diode** $(T_{vj}=25^{\circ}\text{C} \text{ unless otherwise specified})$

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Symbol	Parameter	Test condition	Min.	Тур.	Max.	Onit
W	Die de ferryand velte ce	$I_{\rm F}$ =30A	-	1.4	-	V
$V_{ m F}$	Diode forward voltage	$I_{\rm F}=30{\rm A}, T_{\rm vj}=175{}^{\circ}{\rm C}$	-	1.2	-	V
$t_{ m rr}$	Diode reverse recovery time	$V_{ m R}$ =400V	-	105	-	ns
$I_{ m rrm}$	Diode peak reverse recovery current	$I_{\rm F}$ =30A	-	16	-	A
$Q_{\rm rr}$	Diode reverse recovery charge	$di_{\rm F}/dt$ =-550A/ $\mu$ s	-	876	-	nC
$t_{ m rr}$	Diode reverse recovery time	$V_{ m R}$ =400V $I_{ m F}$ =30A $di_{ m F}/dt$ =-550A/ $\mu$ s	-	171	-	ns
$I_{ m rrm}$	Diode peak reverse recovery current		-	26	-	A
$Q_{ m rr}$	Diode reverse recovery charge	<i>T</i> <sub>vj</sub> =175 ℃	-	2650	-	nC



## **Typical performance characteristics**

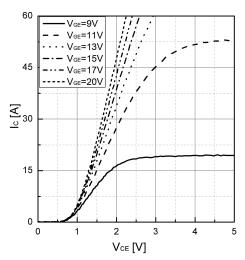


Fig 1. Typical output characteristic ( $T_{vj}$ =25°C)

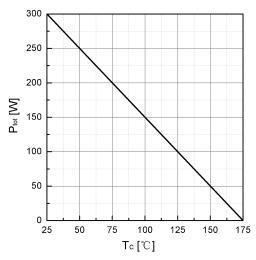


Fig 3. Power dissipation as a function of  $T_C$ 

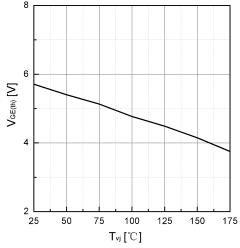


Fig 5. Typical  $V_{\text{GE(th)}}$  as a function of  $T_{\text{vj}}$  ( $I_{\text{C}}=1\,\text{mA}$ )

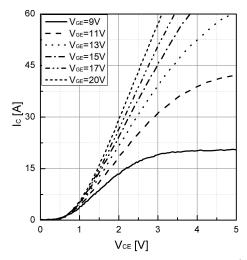


Fig 2. Typical output characteristic( $T_{vj}$ =175°C)

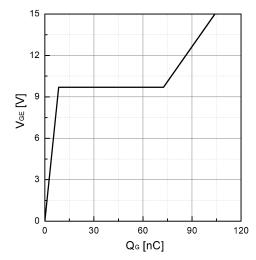


Fig 4. Typical Gate charge

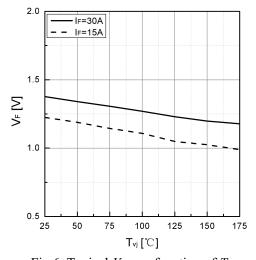


Fig 6. Typical  $V_F$  as a function of  $T_{vj}$ 



#### Typical performance characteristics

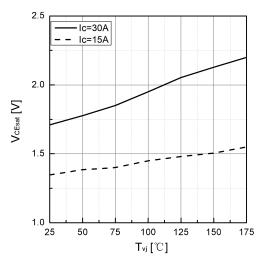


Fig 7. Typical  $V_{\text{CEsat}}$  as a function of  $T_{\text{vj}}$ 

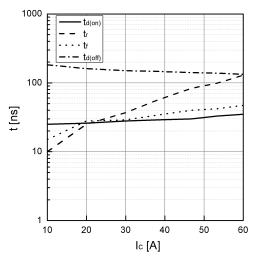


Fig 9. Typical switching time as a function of  $I_{\rm C}$ 

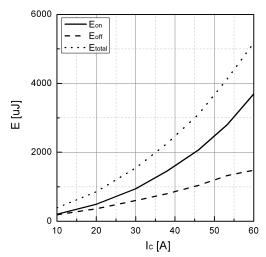


Fig 11. Typical switching energy losses as a function of  $I_{\mathbb{C}}$ 

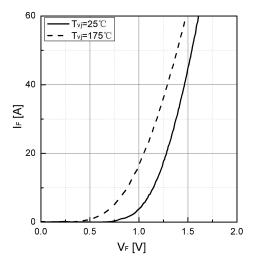


Fig 8. Typical  $I_F$  as a function of  $V_F$ 

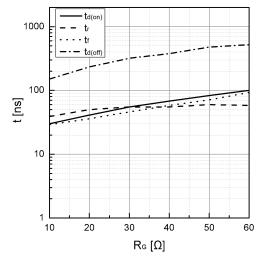


Fig 10. Typical switching times as a function of  $R_G$ 

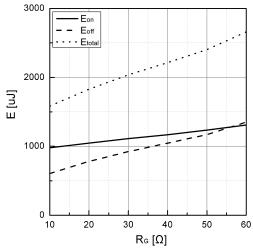


Fig 12. Typical switching energy losses as a function of  $R_G$ 



# **Typical performance characteristics**

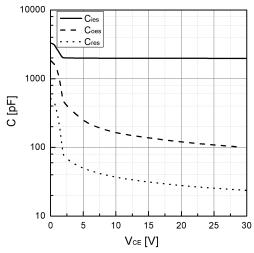


Fig 13. Typical capacitance as a function of  $V_{\rm CE}$  (f=1Mhz,  $V_{\rm GE}$ =0V)

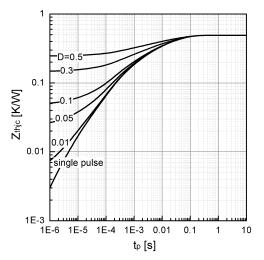
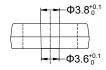


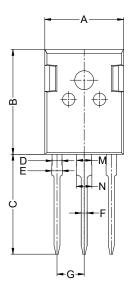
Fig 14. Transient thermal impedance of IGBT

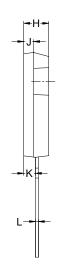


# Package dimension

TO-247







	Dimensions					
Ref.		Millimeters			Inches	
	Min.	Тур.	Max.	Min.	Тур.	Max.
A	15.50	15.80	16.10	0.610	0.622	0.634
В	20.80	21.00	21.20	0.819	0.827	0.835
С	19.70	20.00	20.30	0.776	0.787	0.799
D	1.80	2.00	2.20	0.071	0.079	0.087
Е	1.90	2.10	2.30	0.075	0.083	0.091
F	1.00	1.20	1.40	0.039	0.047	0.055
G	5.25	-	5.65	0.207	-	0.222
Н	4.80	5.00	5.20	0.189	0.197	0.205
J	1.90	2.00	2.10	0.075	0.079	0.083
K	2.20	2.35	2.50	0.087	0.093	0.098
L	0.41	0.60	0.79	0.016	0.024	0.031
M	2.80	3.00	3.20	0.110	0.118	0.126
N	2.90	3.10	3.30	0.114	0.122	0.130



#### **Revision history**

Date	Revision	Changes
2023-12-27	Rev 1.0	Release of the datasheet
2024-03-20	Rev 1.1	Update
2024-05-17	Rev 1.2	Update

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